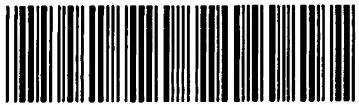


<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10757650	MAUPIN, PATRICK EVAN
Examiner	Art Unit	
Flores, Leon	2611	

### SEARCHED

Class	Subclass	Date	Examiner
375	295, 377, 222, 220	2/26/2007	LF
370	276	2/26/2007	LF
455	39, 73, 91	2/26/2007	LF

### SEARCH NOTES

Search Notes	Date	Examiner
Consulted with SPE David Payne in regards to the patentability of claim 1.	2/27/2007	LF
Checked for Double patenting.	2/26/2007	LF
Consulted with SPE David Payne in regards to the amendments.	5/18/2007	LF

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner